FORM PTO-1449 (MODIFIED) US DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

Atty. Docket No. IN-5421

LIST OF ART CITED BY APPLICANT (Use sever of sheets if necessary)

In re Application of: Valerie L. CRUMLEY et al.

Serial No.: Herewith

Filed: January 17, 2002

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U.S. PATENT DOCUMENTS  Examiner   DOCUMENT NUMBER   DATE   NAME   CLASS   SUBCLASS   FILING DATE IF									
initial							FILING DATE IF APPROPRIATE		
RG_	AA	5,492,731	02/20/96	Temple et al.	427	407.1	05/17/91		
RG	AB	4,954,559	09/04/90	Den Hartog et al.	524	507	9/5/89		
RG	AC	5,397,646	03/14/95	Nickle et al.	428	423.1	12/29/93		
RE	AD	5,589,543	12/31/96	Yokelson et al.	525	131	11/2	7/95	
RG	AE	5,591,820	01/07/97	Kydonieus et a	528	76	5/9/9	5	
RG	AF	5,670,600	09/23/97	Nienhaus et al.	528	75	6/18/94		
RG	AG	5,876,802	03/02/99	Brünnemann et al.	427	409	10/28/95		
RG	AH	5,993,911	11/30/99	Brenke et al.	427	407.1	7/30/96		
RG	Al	5,618,859	04-1997	Maeyama et al.	523	201	8/25/95		
RG	AJ	5,492,731	02-1996	Temple et al.	427	407.1	5/17/91		
RG	AK	5,578,669	11-1996	Odawa et al.	524	414	12/20/94		
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	AK	Abstract of Kansai, "Polyester-polyurethane compositions as chipping-resistant automotive primers", JP 63-122768, filed on 5/1988							
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<sup>\*</sup>Applicant has modified this form by deleting the word "prior".

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<u> </u>	AA	5,593,785	01-1997	Mayo et al.	428	423.1	6/26/95	
RG_	AB	5,114,485	05-1992	Lynch et al.	106	311	5/1/91	
RE	AC	6,057,400	05-2000	Kinney et al.	524	591	6/6/9	6
RG	AD	6,210,758	4/3/01	McNeil, et al.	427	409	11/17/99	
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263	AA	4,948,829	08/14/90	Mitsuji et al.	524	04	05/05/89				
RG	AB	5,011,881	04/30/91	Fujii et al.	524	457	01/16/90				
26	AC	5,141,983	08/25/92	Hasegawa et al.	524	457	12/17/91				
RG	AD	5,227,422	07/13/93	Mitsuji et al.	524	457	08/21/91				
RG	AE	5,281,655	01/25/94	Mitsují et al.	524	507	07/22/92				
RG	AF	5,314,942	05/24/94	Coogan et al.	524	457	07/02/93				
RG	AG	5,586,384	12/24/96	Newman	29	596	04/28/95				
RG	АН	5,739,194	04/14/98	Natesh et al.	524	457	06/24/96				
RG	Al	5,817,735	10/06/98	Hatch et al.	528	84	02/07/96				
RG	AJ	5,854,332	12/29/98	Swarup et al.	524	507	12/20/96				
RG	AK	4,978,708	12/18/90	Fowler et al.	524	507	04/25/89				
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00	AR			Polymer Science ar	nd Engine	ering", 2nd	ed.;				
5		Academic Press;	New York,	1999; pp. 53-56,							
RG	AS	Szycher, M. "Szy	cher's Hand	lbook of Polyurethar	nes''' CRC	Press; Wa	shington, 、				
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